Diagnostics and instrumentation at SQS



Thomas Baumann Small Quantum Systems (SQS) Instrument

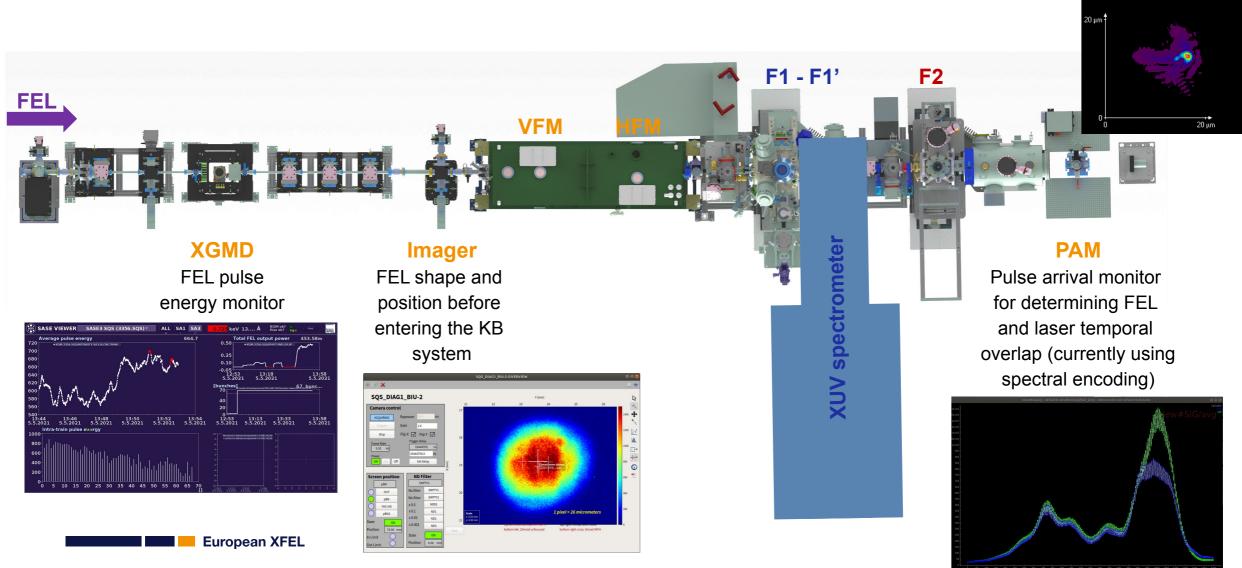
Schenefeld, 21.10.2021

Outline

- Overview on FEL diagnostics at SQS
 - Pulse energy
 - Wavefront analysis
 - Timing diagnostics
 - Spectral distribution
 - Additional instrumentation
 - Photo-electron spectrometer (PES)
 - AQS electron spectrometers

Diagnostics overview – what we have today

Wavefront sensor FEL focus characterization

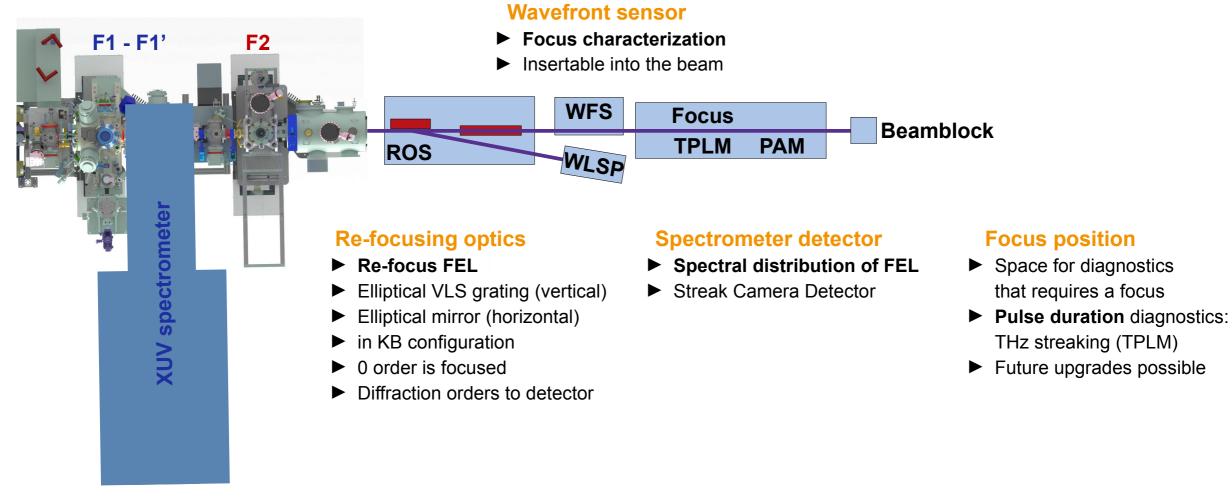


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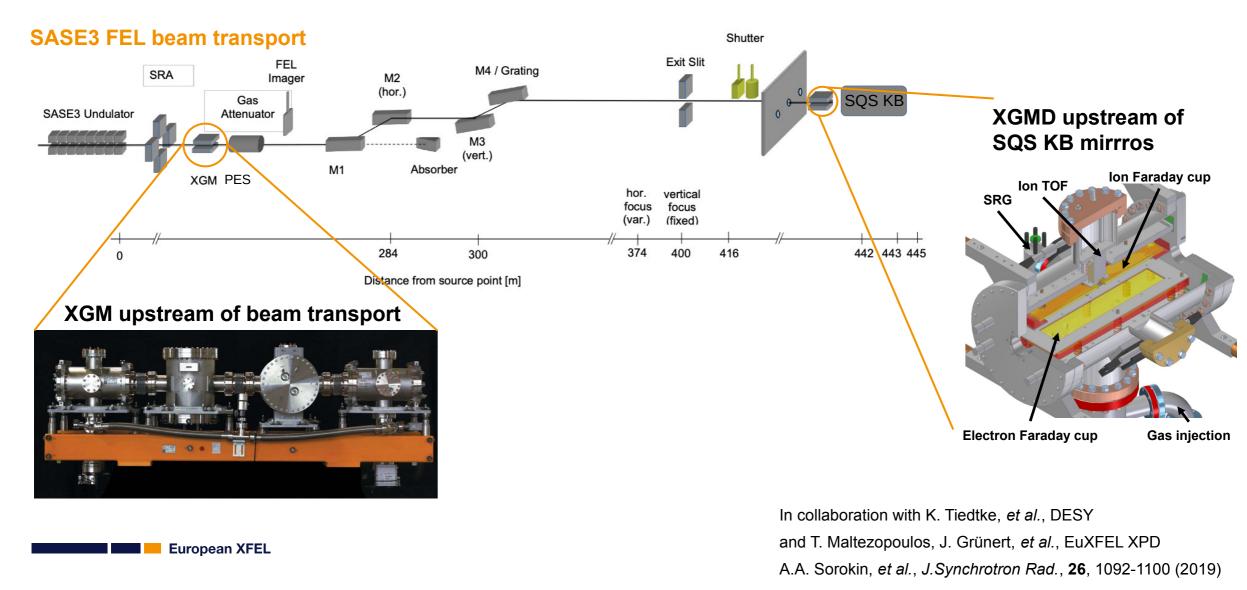
that requires a focus

THz streaking (TPLM)

Diagnostics overview – DIAG3 upgrade in 2022

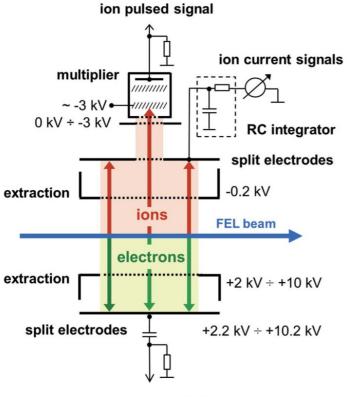


Pulse energy measurement



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Pulse energy measurement



electron pulsed signals

European XFEL

 Absolute determination of pulse energy from photo-ion current (slow): Photo-ionization of target gas (usually Krypton or Xenon). Measurement of photo-ion current. Measurement of gas pressure and temperature. Number of incoming photons can be calculated using photo-ionization cross section and average photo-ion charge state.
Uncertainty < 5%. Pulse-resolved measurement using photo-electrons (fast):
Measurement of photo-electrons for each FEL pulse.
Signal recorded on digitizers after amplification.Calibrated on slow pulse energy measurement.
Uncertainty < 10%. XGM allows for beam position measurement using split electrodes.

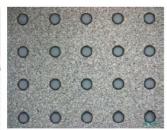
In collaboration with K. Tiedtke, et al., DESY

and T. Maltezopoulos, J. Grünert, et al., EuXFEL XPD

A.A. Sorokin, et al., J.Synchrotron Rad., 26, 1092-1100 (2019)

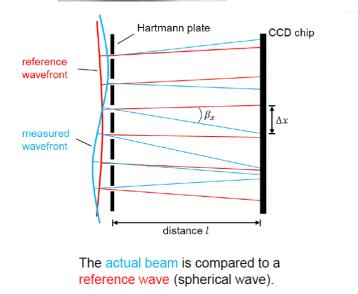
Wavefront measurement





Hartmann plate

- Measures FEL wavefront compared to reference spherical wave.
- Pinhole array (Hartmann plate) and x-ray sensitive CCD camera.
- Back propagation of wavefront to determine focus properties.
- Software for online analysis.
 - Current wavefront sensor is installed at the end of the beamline.



European XFEL

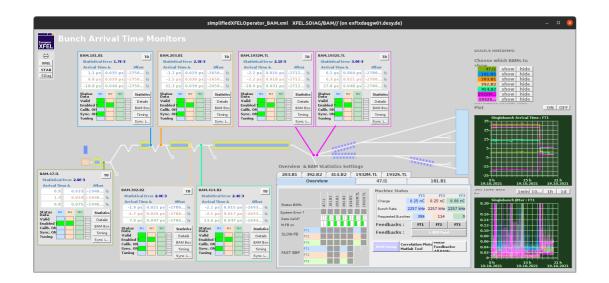
20 μm
 1050 eV
 20 μm

Upgrade in 2022:

- Sensor specifically developed for SQS.
- Entire set-up can be moved into the beam when needed.

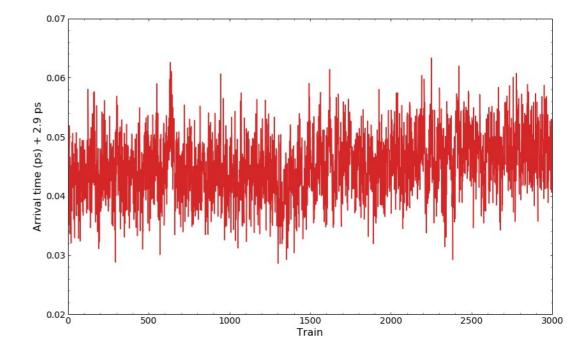
In collaboration with B. Keitel, E. Pjönjes-Palm, *et al.*, DESY and K. Mann, *et al.*, IFNANO Göttingen B. Keitel, et al., *J. Synchrotron. Rad.* **23**, 43-49 (2016)

FEL / laser timing diagnostics: BAM (Bunch Arrival Monitor)



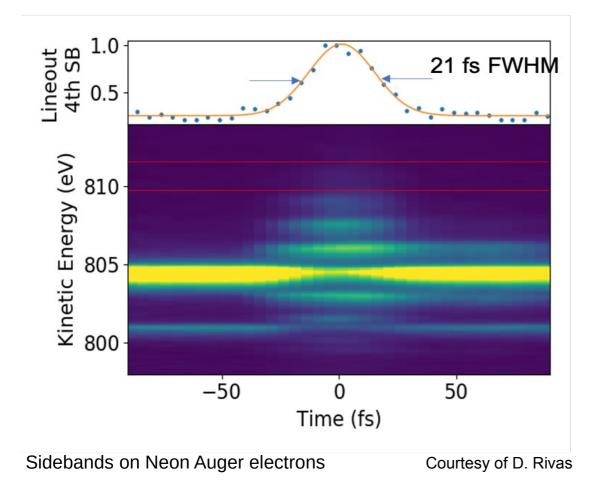
Measures relative arrival time of the electron bunch.

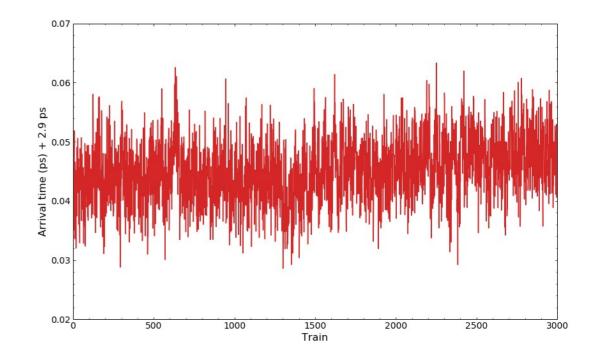
- RF pick-ups detect electron bunch in the accelerator.
- RF signal is compared to master oscillator by electro optical modulator.
- Used for feedback system to stabilize arrival time.



Thomas Baumann, 21.10.2021

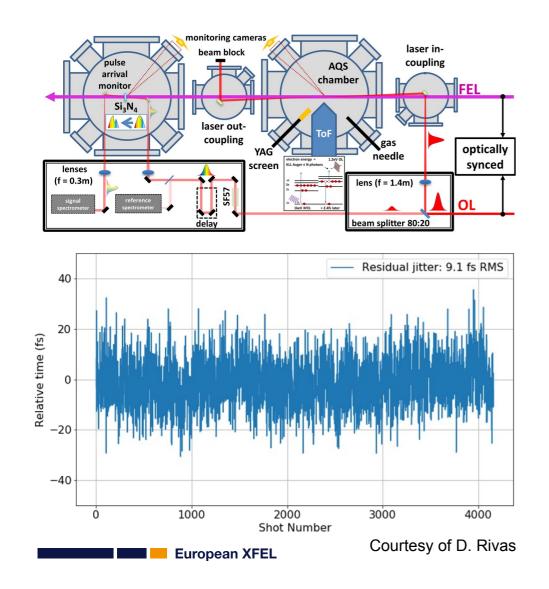
FEL / laser timing diagnostics: BAM (Bunch Arrival Monitor)





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FEL / laser timing diagnostics: PAM (Pulse Arrival Monitor)



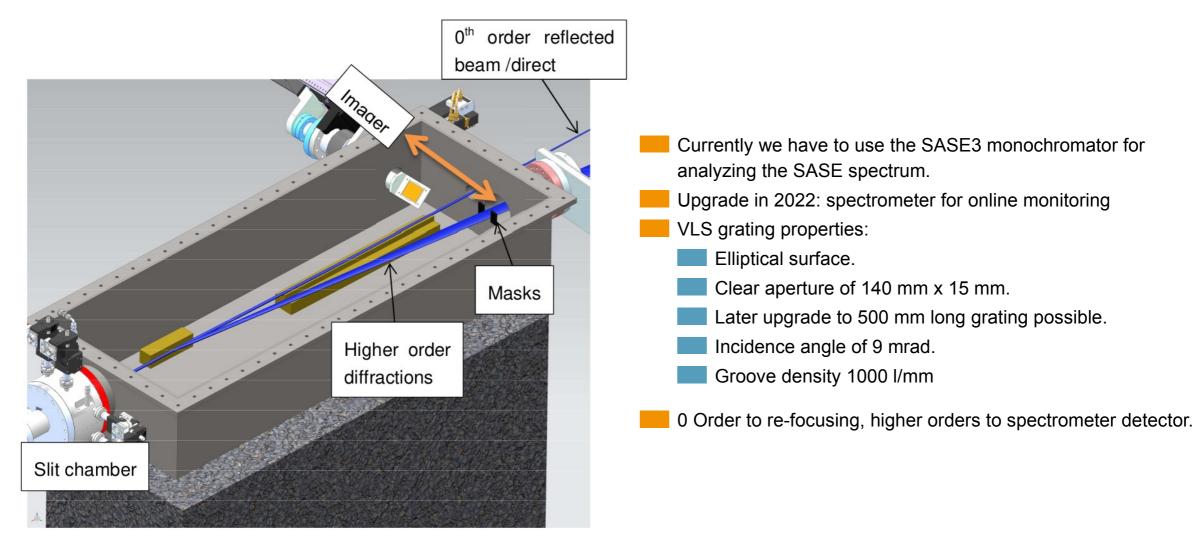
- Pulse arrival monitor to measure temporal overlap of FEL and laser.
- Based on spectral encoding.
- Target: Si₃N₄ or YAG.

Measured arrival jitter < 10 fs (RMS) (convolution of FEL jitter and PAM accuracy).

- Uses second laser arm split from main laser beam.
- Cannot measure long term drifts of FEL arrival time.
- Only usable in limited parameter space (FEL energy and pulse energy, laser power, repitition rate).
- We are looking into alternatives and further improvements.

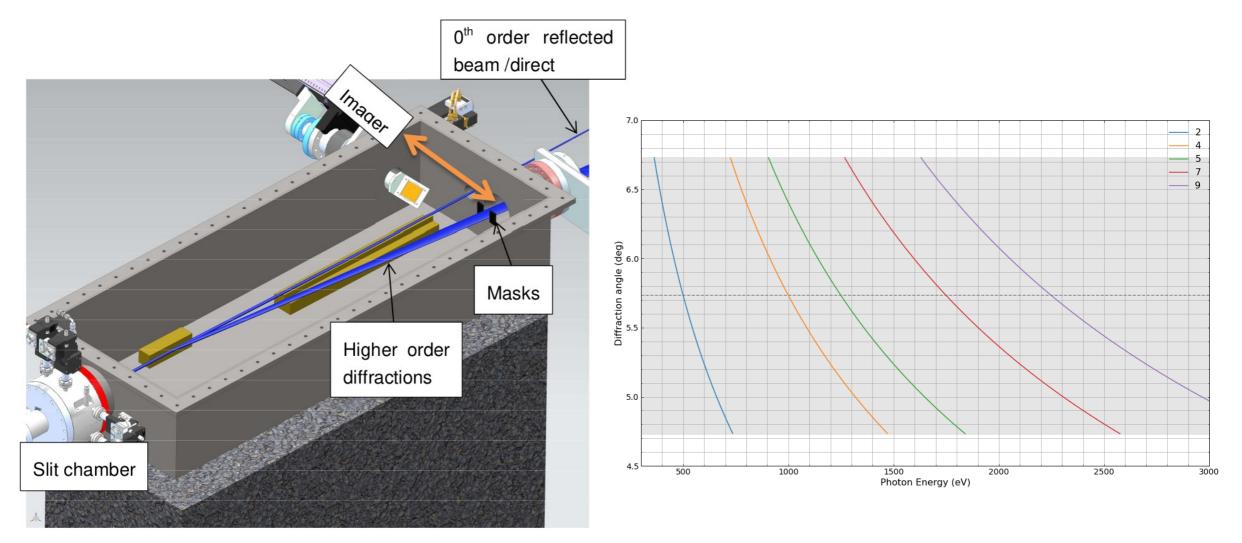
In collaboration with J. Liu, J. Grünert, *et al.*, EuXFEL XPD M.R. Bionta, *et al.*, *Opt. Exp.*, **19**, 21855 (2011) P. Grychtol, *et al.*, *Opt. Exp.*, to be published soon

FEL spectrum: re-focusing optics and spectrometer



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FEL spectrum: re-focusing optics and spectrometer



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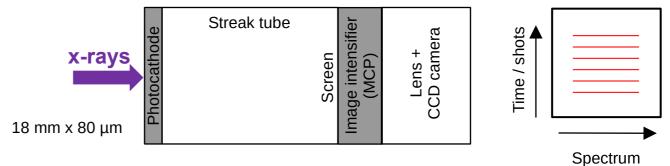
FEL spectrum: streak camera

Hamamatsu X-ray Streak Camera (C7700)

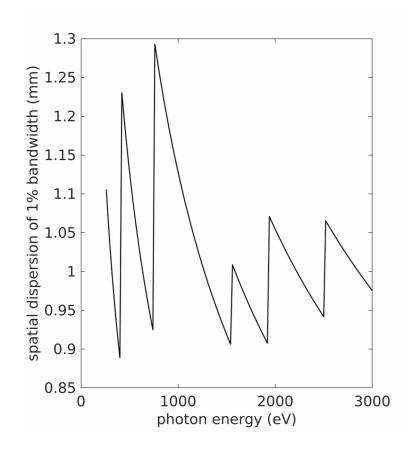
Enables pulse-resolved measurements.

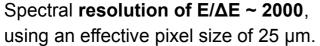
Spacial resolution about 25 µm.

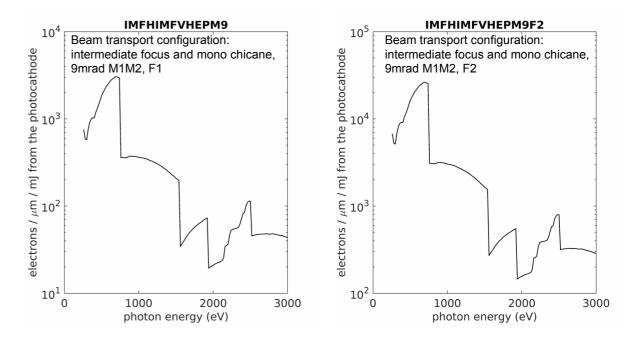




FEL spectrum: expected performance



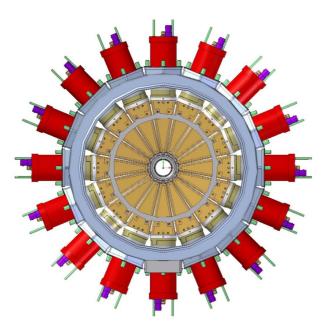


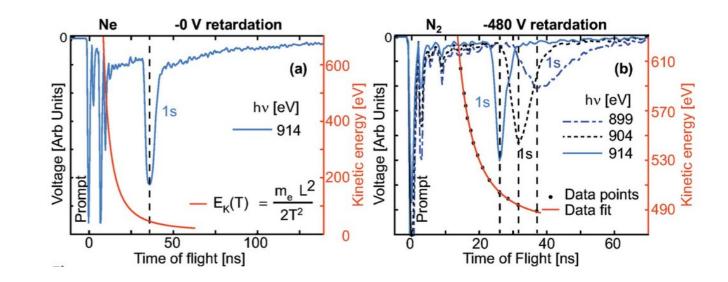


Includes beamtransport transmission, photocathode size and efficiency, grating efficiency. The streak camera has a gain factor of ~1000 on top of these numbers.

\rightarrow single shot capability

Photo Electron Spectrometer (PES) at SASE3





Array of 16 electron time-of-flight spectrometers.

- Located in the SASE3 tunnel upstream of mirrors.
- Can be used to record pulse-resolved FEL spectrum measuring photoelectron spectra.

Resolution about 0.1%

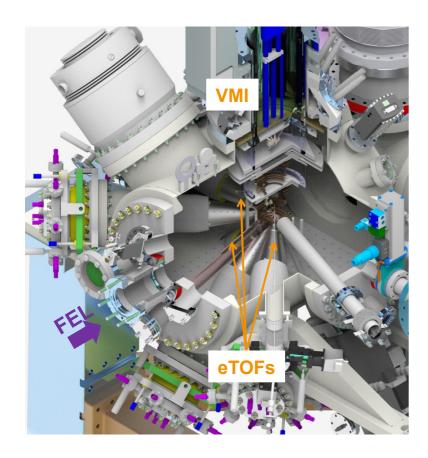
European XFEL

In collaboration with J. Laksman, J. Grünert, et al., EuXFEL XPD

J. Buck, et al., XFEL.EU TR-2012-002

J. Laksman, et al. J. SynchrotronRad., 26, 1010–1016 (2019).

AQS spectrometers



- Electron Time-of-Flight spectrometers (also for ions)
 - Angle resolved: 6 ToFs at different angles
 - Acceptance of 0.14% of 4pi
 - Electron energy range: 5 eV 5000 eV
 - Electron energy resolution $E/\Delta E > 10000$ at 811 eV
- Velocity Map Imaging Spectrometer (VMI)
 - For electrons or ions
 - 4pi acceptance
 - Energy resolution of few percent
- FEL size about 1 mm in F1 when focusing in F1'

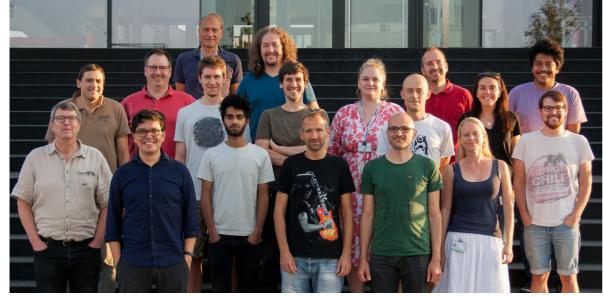
Thanks to everybody

SQS Instrument team

Michael Meyer

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European XFEL

Jan Grünert Andreas Koch Joakim Laksman Jia Liu Theophilos Maltezopoulos

and many more...

DESY

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IFNANO Göttingen

Klaus Mann Bernd Schäfer Jens-Oliver Dette

and many more ...